

# Today's outline - March 05, 2020

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No class on Tuesday, March 24, 2020 or Thursday, March 26, 2020



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Homework Assignment #04:

Chapter 4: 2, 4, 6, 7, 10

due Tuesday, March 10, 2020

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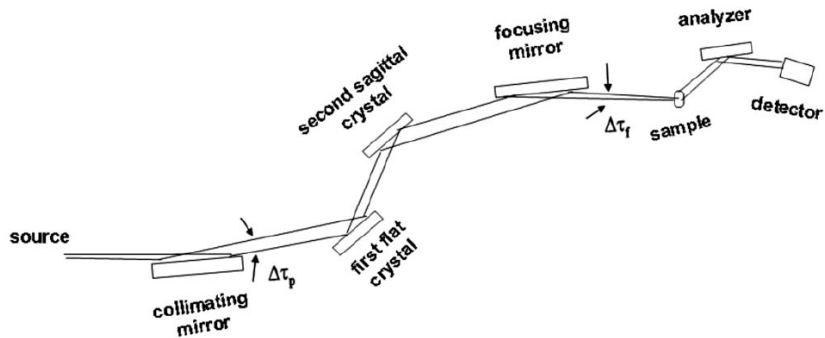
due Tuesday, March 10, 2020

Homework Assignment #05:

Chapter 5: 1, 3, 7, 9, 10

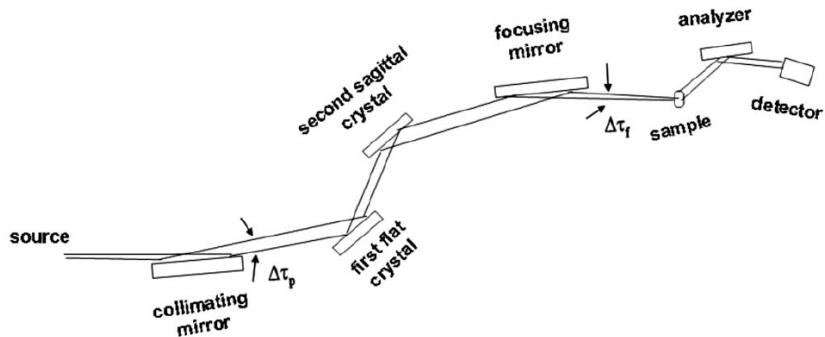
due Thursday, April 02, 2020

# Beamline 11BM at the APS



"A dedicated powder diffraction beamline at the Advanced Photon Source: Commissioning and early operational results," J. Wang et al. *Rev. Sci. Instrum.* **79**, 085105 (2008).

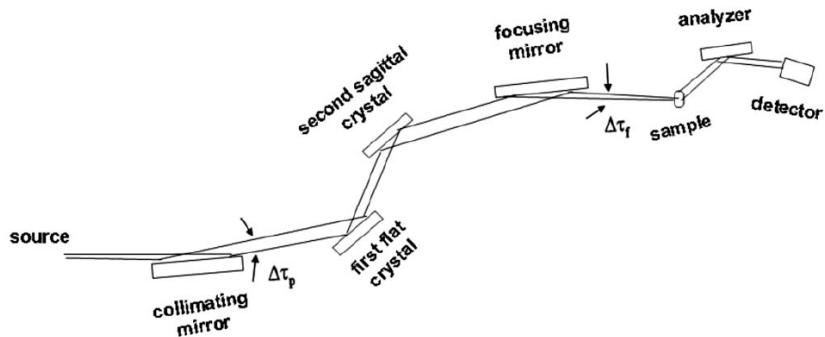
# Beamline 11BM at the APS



2D detectors have limited angular resolution, for high resolution routine powder diffraction, beamlines such as 11BM are ideal

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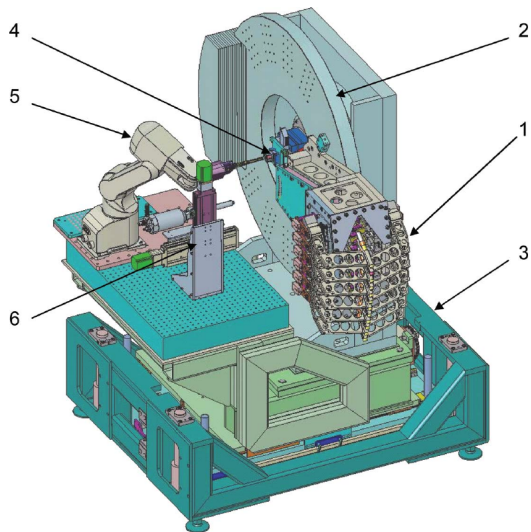


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The initial collimating mirror makes the beam more parallel and then it is focused horizontally and vertically to the sample

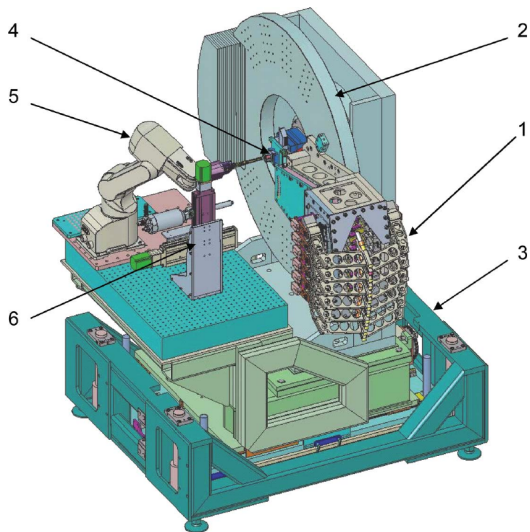
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# The high resolution analyzer



"A twelve-analyzer detector system for high resolution powder diffraction," P.L. Lee et al. *J. Synch. Rad.* **15**, 427-432

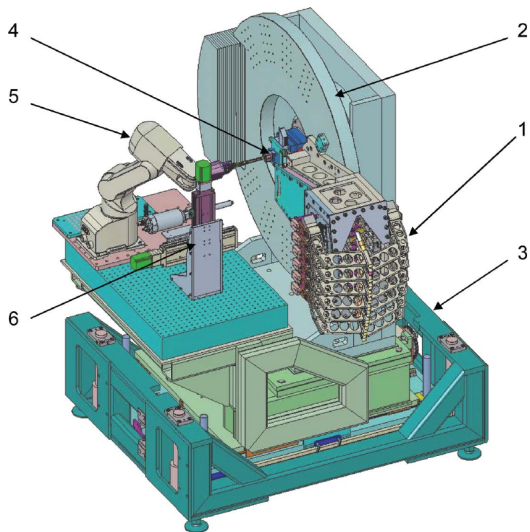
# The high resolution analyzer



High throughput is obtained using a robot arm to change samples

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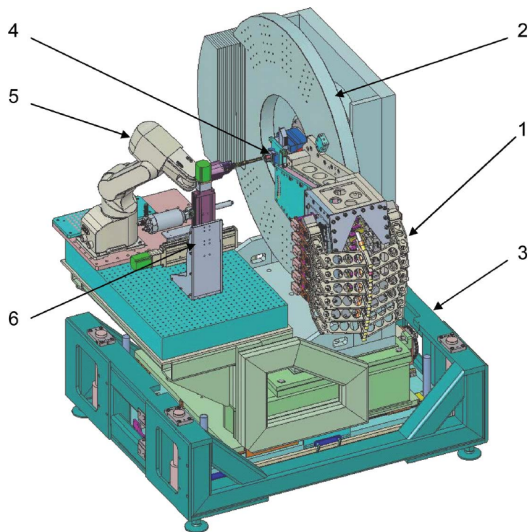
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The sample is mounted on a rotating spindle at the center of the goniometer

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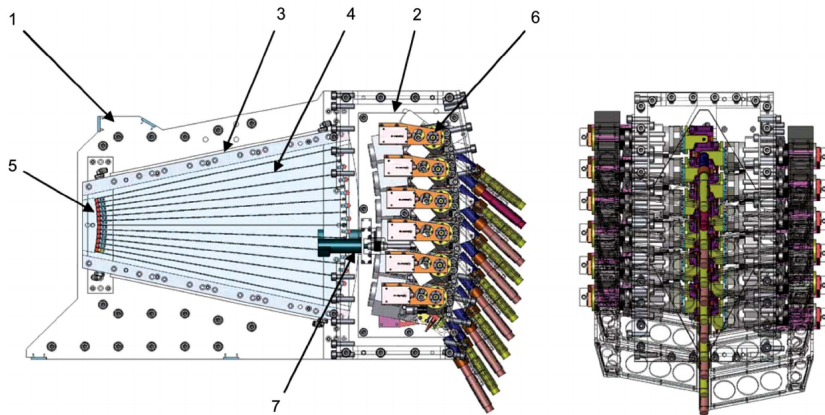
High throughput is obtained using a robot arm to change samples

The sample is mounted on a rotating spindle at the center of the goniometer

High resolution is achieved with a 12 crystal analyzer system which is rotated on the main circle of the goniometer

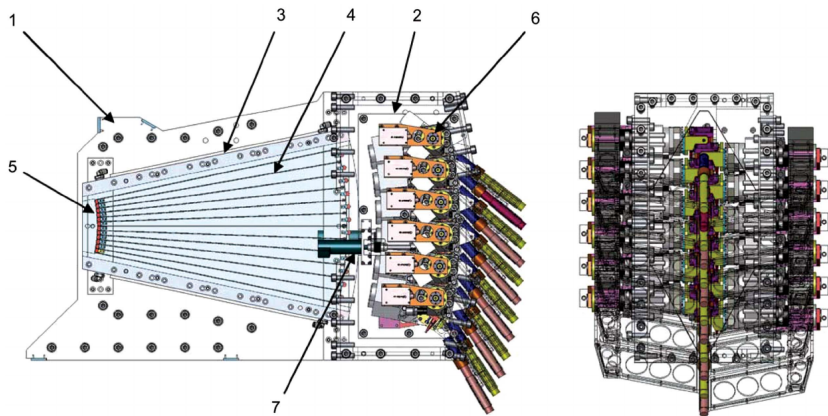
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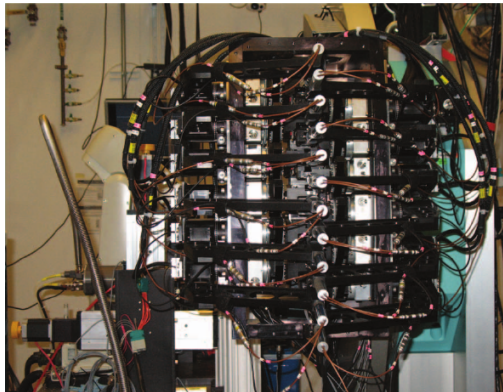
# The high resolution analyzer



Each of the 12 analyzer crystals is tuned to the desired scattering energy and as the entire assembly is scanned, all twelve banks are collecting data and then are merged

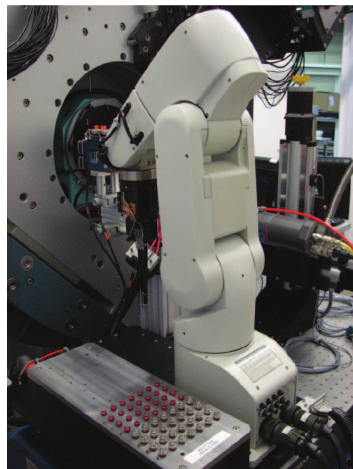
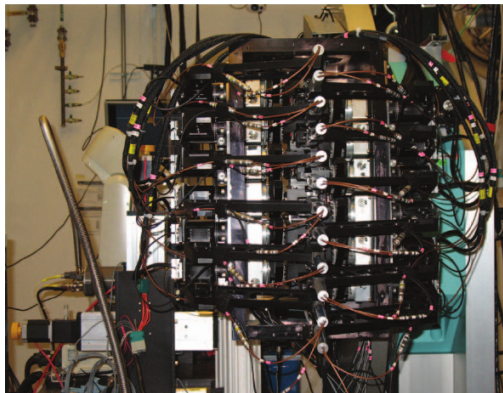
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# The analyzer and robot arm



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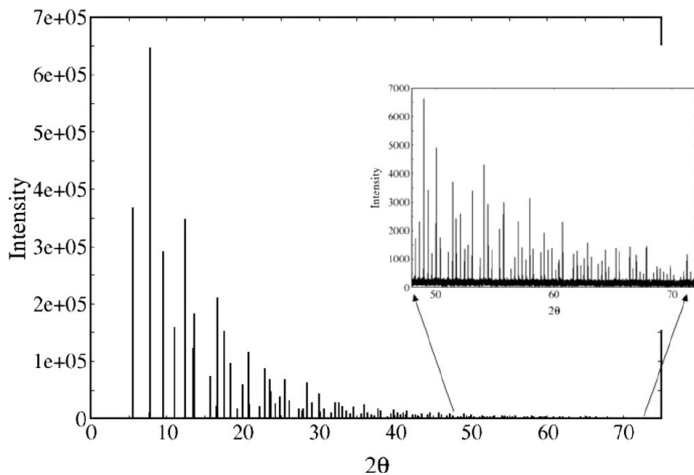
# The analyzer and robot arm



Samples are in Kapton capillaries and magnetic bases for remote mounting

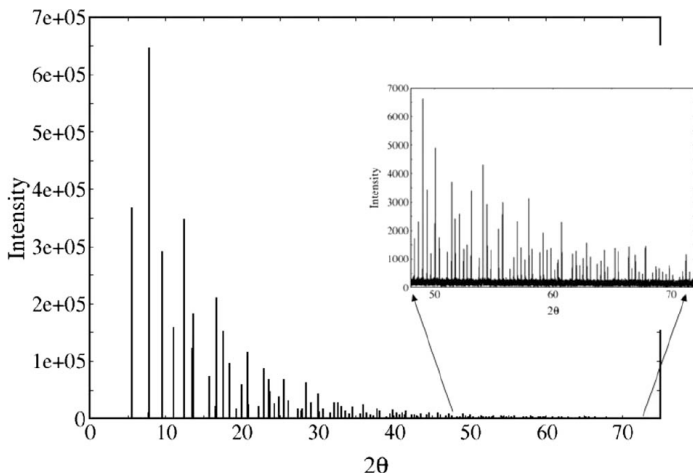
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# Data from high resolution LaB<sub>6</sub> standard



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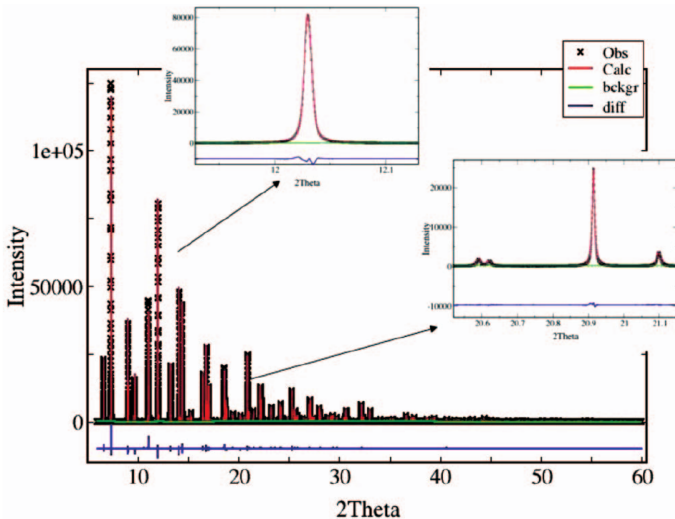
# Data from high resolution LaB<sub>6</sub> standard



High resolution data with high count rates can be obtained out to very high angles with a wavelength of  $\lambda \approx 0.5\text{\AA}$ .

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# Refinement of $\text{SiO}_2$ and $\text{Al}_2\text{O}_3$



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# CaO-CaO<sub>2</sub> reaction kinetics

CaO is a possible material to be used for carbon sequestration

A. Biasin, C.U. Segre, G. Salviulo, F. Zorzi, and M. Strumendo, *Chemical Eng. Sci.* **127**, 13-24 (2015)

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CaO will absorb CO<sub>2</sub> at temperatures as low as 450°C forming CaCO<sub>3</sub> and can be regenerated by calcination at temperatures above 700°C

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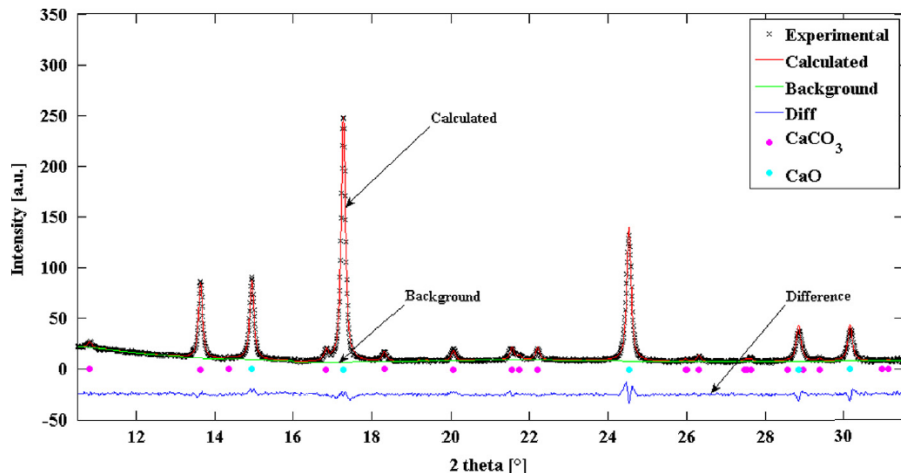
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Rietveld refinement was used to measure the lattice parameters, crystallite sizes and phase fractions during carbonation and calcination cycles

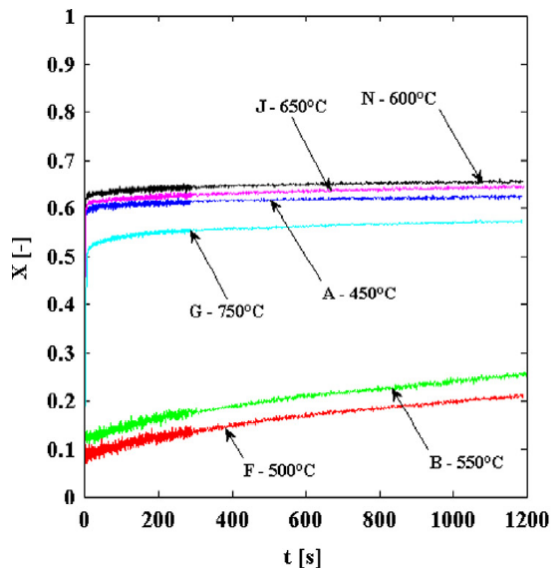
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# Typical diffracton pattern



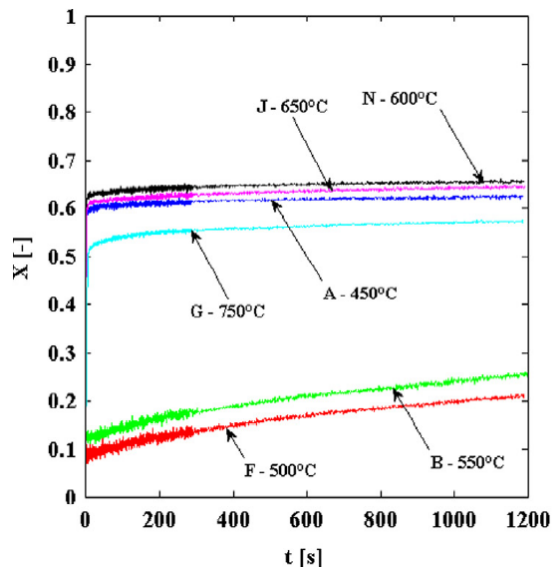
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# Final conversion fraction



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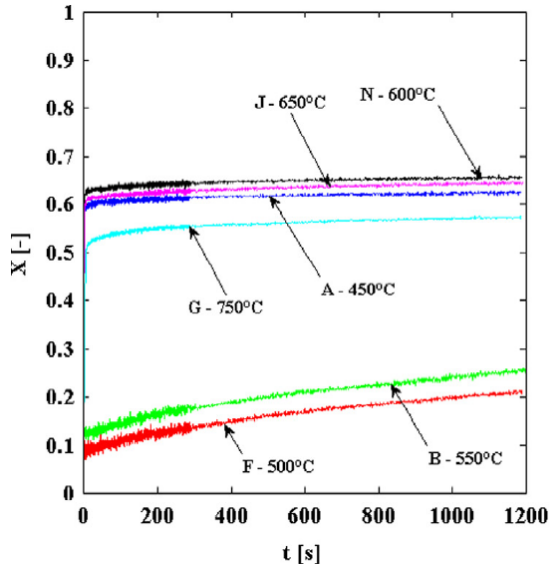
# Final conversion fraction



Final conversion fraction depends on temperature but also some other parameter (what?)



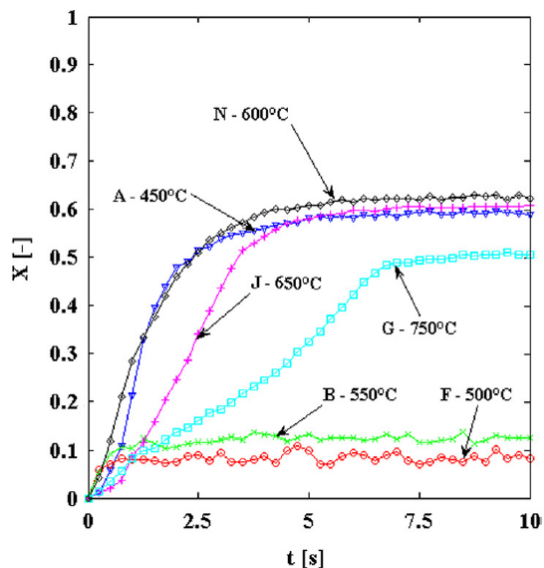
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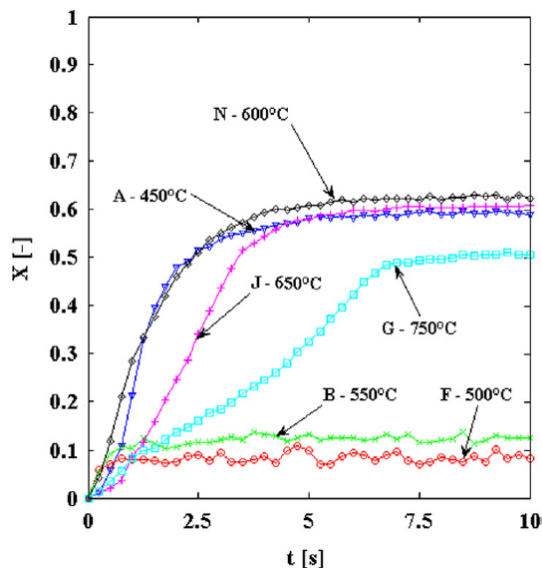
Remember that these powders have only been sieved to a particular grain size, what about the internal structure?

# CaO-CaO<sub>2</sub> reaction kinetics



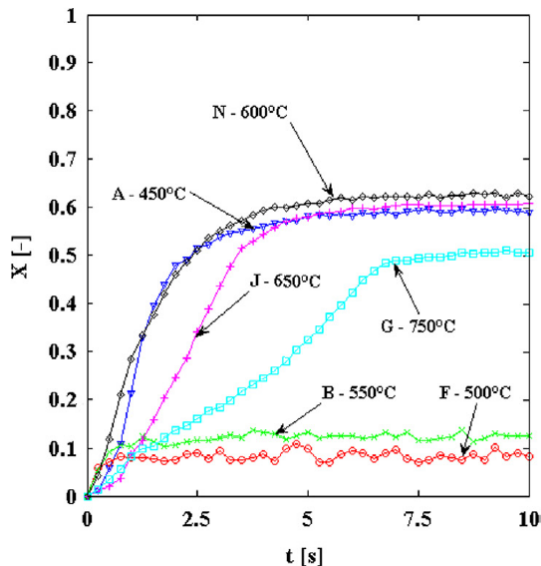
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Because of the high speed of the 2D detector, it is possible to look at the conversion reaction at unprecedented time scales

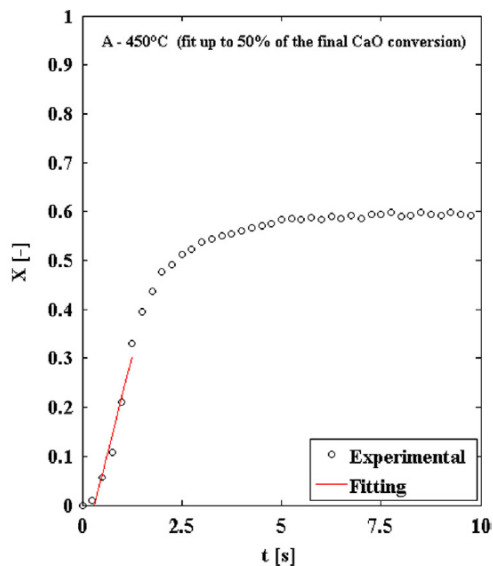
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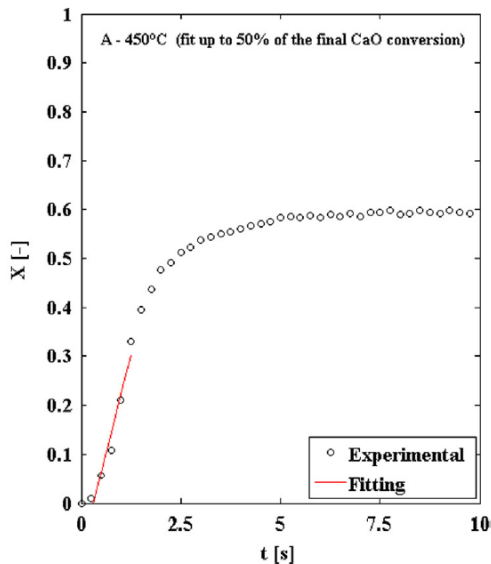
Reaction kinetics much faster,  $1/\tau = 0.28 \text{ s}^{-1}$ , than previously observed with TGA measurements

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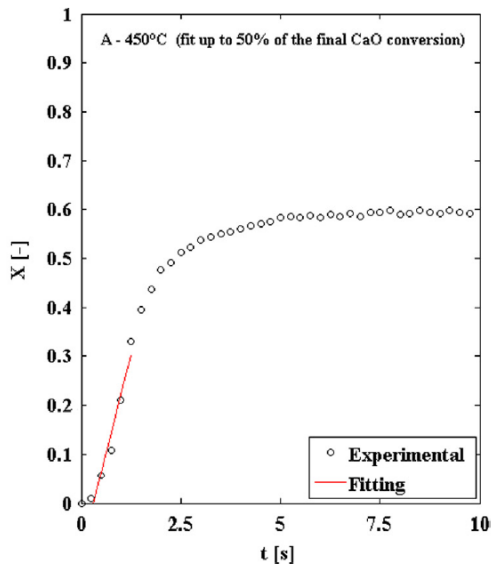
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The rates of conversion are determined by fitting the initial (up to 50%) slope of the phase fraction as a function of time with a straight line

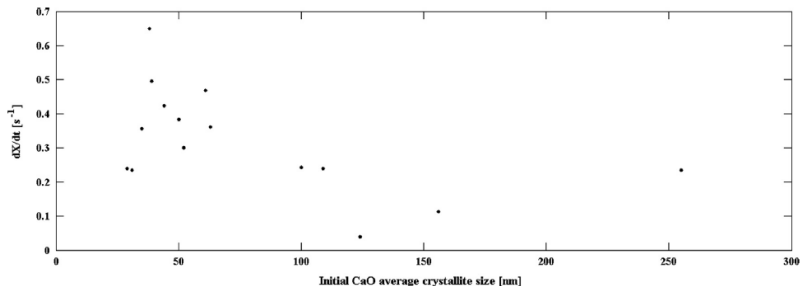
# CaO-CaO<sub>2</sub> reaction kinetics



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These data are then plotted versus the initial CaO crystallite size as determined by Rietveld refinements

## CaO-CaO<sub>2</sub> reaction kinetics



Initial crystallite size is one of the determining factors in initial rate of conversion and fraction converted.

CaO crystallite size can be related to porosity which is key to the conversion process.

A. Biasin, C.U. Segre, G. Salviulo, F. Zorzi, and M. Strumendo, *Chemical Eng. Sci.* **127**, 13-24 (2015)



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By treating powder diffraction patterns using total scattering methods it is possible to study disorder in crystalline materials as well as nanocrystalline materials

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where the first term is simply the self-scattering from all the atoms in the sample and we define the discrete scattering intensity,  $I_d(\vec{Q})$ , as:

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$$I_d(\vec{Q}) = I_c(\vec{Q}) - N \langle f(\vec{Q})^2 \rangle = \sum_{n,m \neq n} f_m(\vec{Q}) f_n^*(\vec{Q}) e^{i\vec{Q}\cdot(\vec{r}_n - \vec{r}_m)}$$



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The total scattering structure function,  $S(\vec{Q})$  is given in terms of the discrete scattering intensity

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$$F(Q) = Q[S(Q) - 1]$$

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where  $\langle f \rangle$  is the sample averaged scattering power

if  $\vec{Q}$  is taken to be in the  $\hat{z}$  direction and the sample is assumed to be isotropic, angular averaging gives

$$S(Q) - 1 = \frac{1}{N\langle f \rangle^2} \sum_{n,m \neq n} f_m(Q) f_n^*(Q) \frac{\sin Qr_{mn}}{Qr_{mn}}$$

and the reduced total scattering structure function,  $F(Q)$  is

$$F(Q) = Q[S(Q) - 1] = \frac{1}{N\langle f \rangle^2} \sum_{n,m \neq n} f_m(Q) f_n^*(Q) \frac{\sin Qr_{mn}}{r_{mn}}$$



## PDF modeling

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$$G(r) = 4\pi r[\rho(r) - \rho_0],$$

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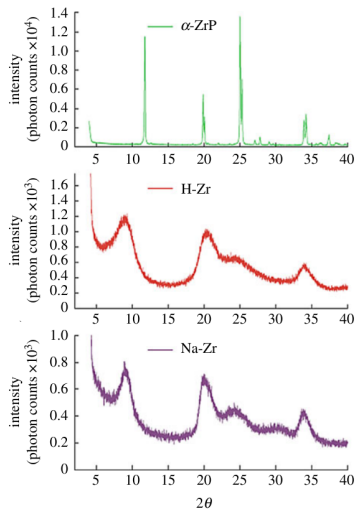
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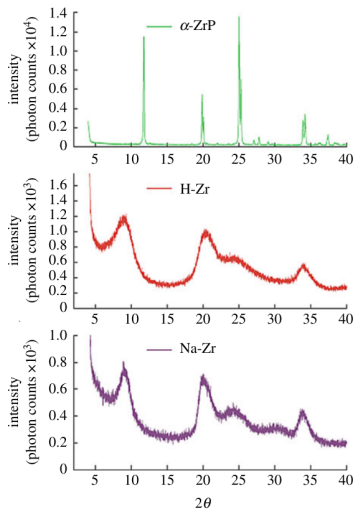
So what does the pair distribution function look like in practice?



# PDF processing: $F(Q)$

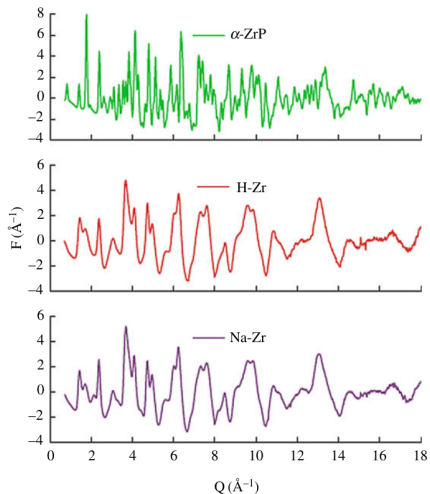
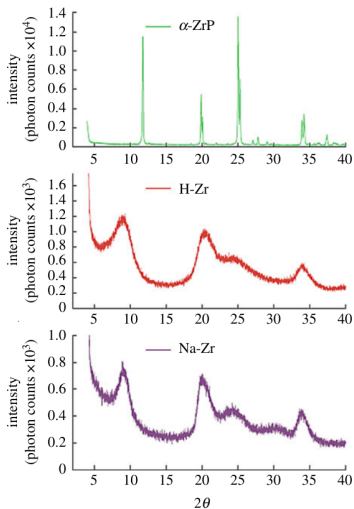


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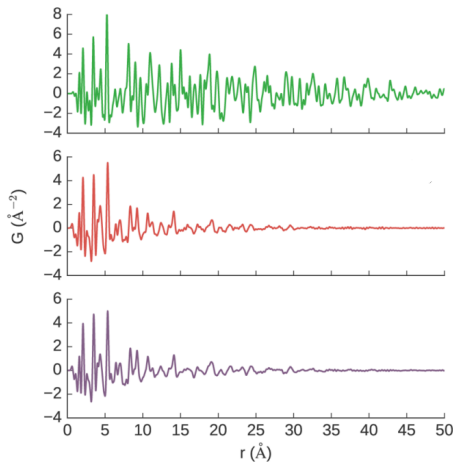
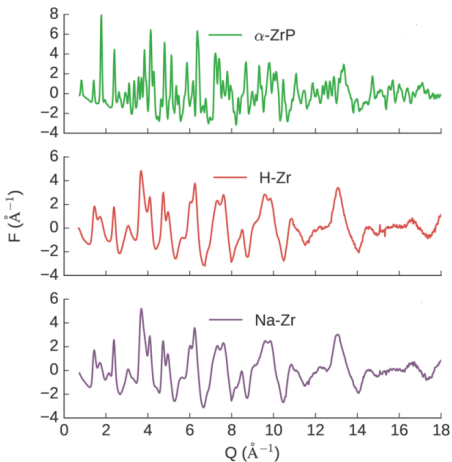
The broad peaks of nanoparticle systems still contains information once processed into the reduced total scattering function

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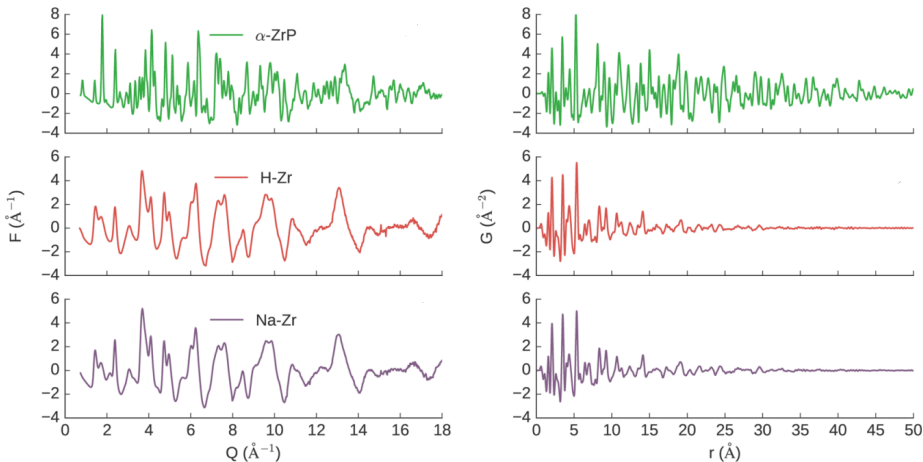
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# PDF processing: $G(r)$



"Local environment of terbium(III) ions in layered nanocrystalline zirconium(IV) phosphate – phosphate ion exchange materials," M.W. Terban, et al. *Inorg. Chem.* **56**, 8837-8846 (2017).

# PDF processing: $G(r)$



When Fourier transformed, the significant differences in crystalline and nanoparticulate samples are obvious

"Local environment of terbium(III) ions in layered nanocrystalline zirconium(IV) phosphate – phosphate ion exchange materials," M.W. Terban, et al. *Inorg. Chem.* **56**, 8837-8846 (2017).

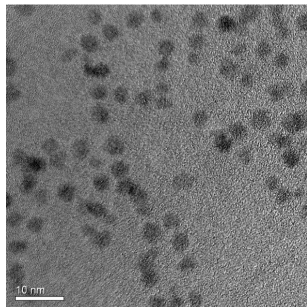
# PDF structure of CdSe nanoparticles

The goal of this study was to compare the PDF structures of CdSe nanoparticles of various sizes with the results obtained from traditional analysis of optical data and electron microscopy

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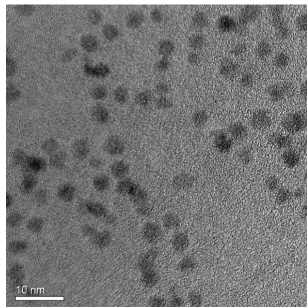


Nanoparticles of three different sizes were obtained by changing the nucleation time from 1200 s (left)

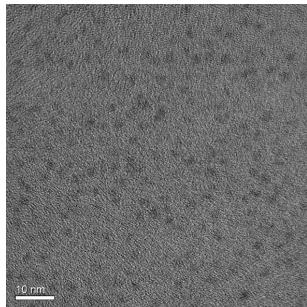
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Nanoparticles of three different sizes were obtained by changing the nucleation time from 1200 s (left) to 15 s (right) during synthesis

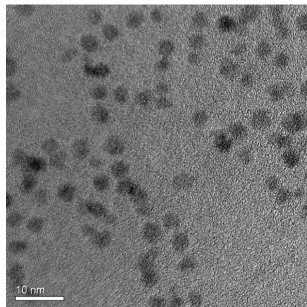


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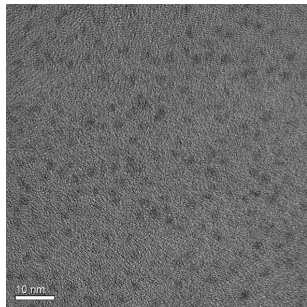


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Optical absorbance and fluorescence indicates that the particle sizes range from 3.5 nm to 2.0 nm

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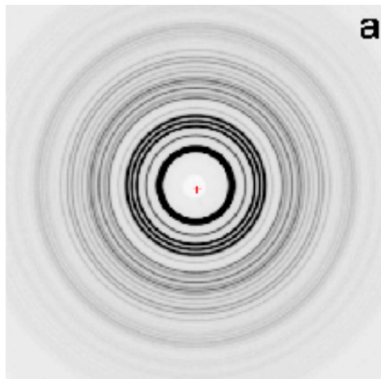
## PDF data collection

Diffraction data were collected at APS beamline 6-IDD with incident 87 keV x-rays on a 2D image plate detector

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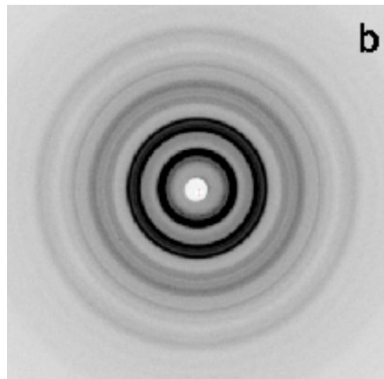
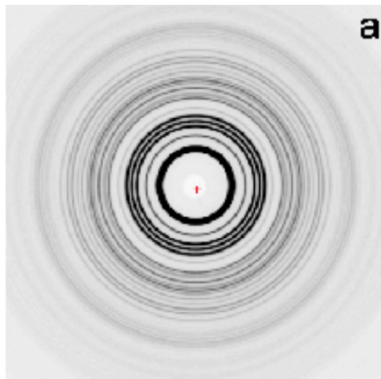


Data were collected on bulk CdSe (left)

"Quantitative size-dependent structure and strain determination of CdSe nanoparticles using atomic pair distribution function analysis," A.S. Masadeh, et al. *Phys. Rev. B* **76**, 115413 (2007).

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Data were collected on bulk CdSe (left) and the CdSe nanoparticles (right) then azimuthally integrated to get the powder pattern

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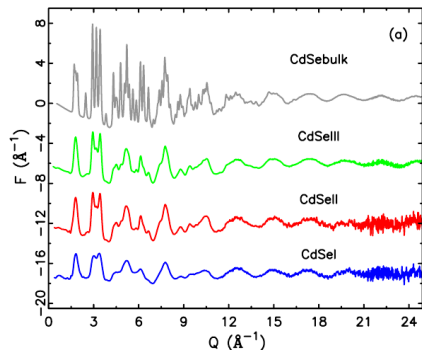
## $F(Q)$ and $G(r)$

The data for bulk and nanoparticle samples was processed to obtain  $F(Q)$  and  $G(r)$  in preparation for structural modeling

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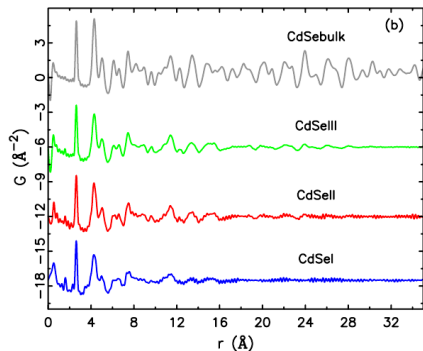
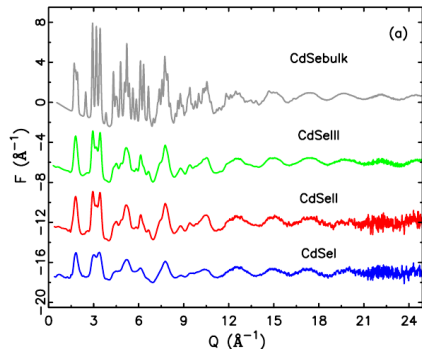
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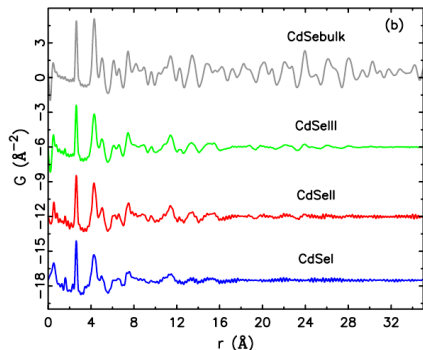
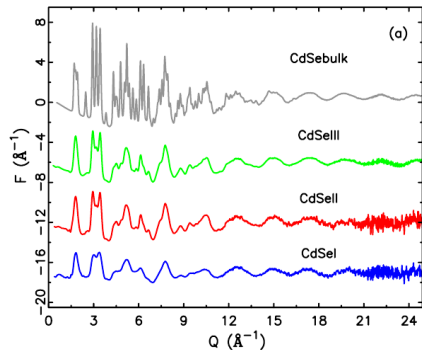
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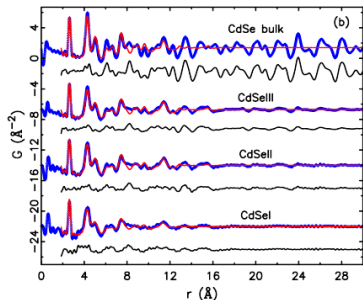


The particle size progression shows in the range over which the  $G(r)$  has distinct peak structure

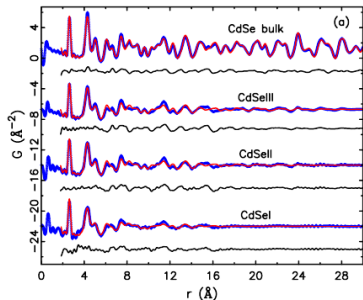
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# Initial modeling

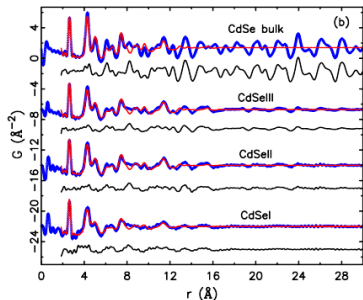


The top panel shows the fit to the data using the wurtzite structure which has ABAB stacking of hexagonal planes



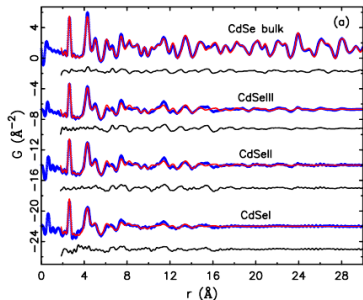
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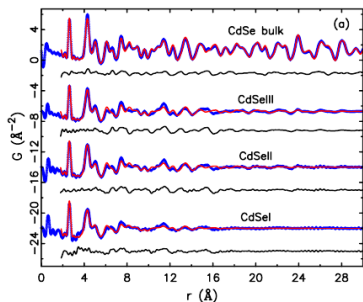
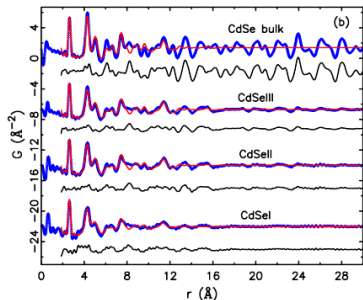
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The bottom panel shows the fit using the zinc blende structure with ABC stacking



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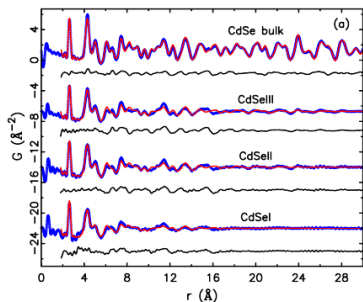
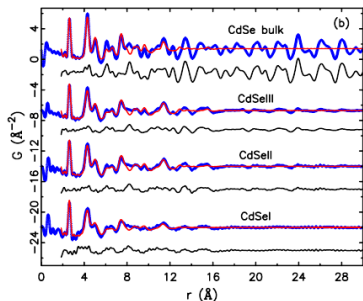
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While the zinc blende does slightly better at fitting the experimental data, it is clear that neither is perfect for the bulk or the nanoparticles

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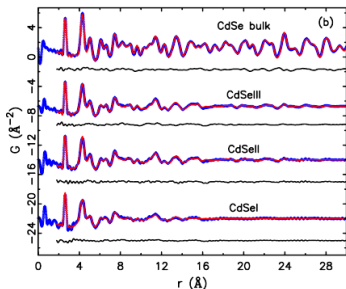
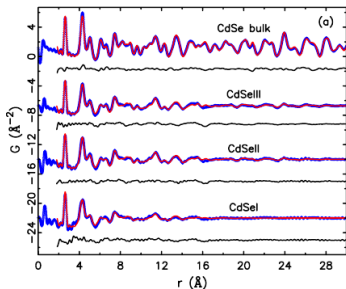
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While the zinc blende does slightly better at fitting the experimental data, it is clear that neither is perfect for the bulk or the nanoparticles

It is likely that a better fit can be obtained using a mixture of the two stacking arrangements

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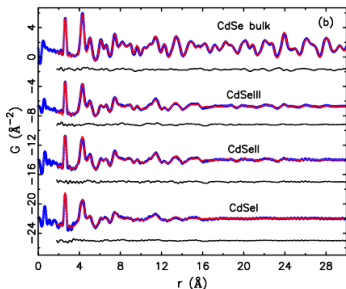
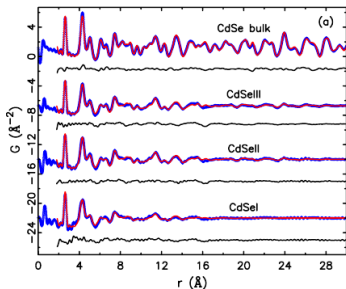
# Final structural models



The top panel shows a fit using both wurtzite and zinc blende which fits much better for all particles

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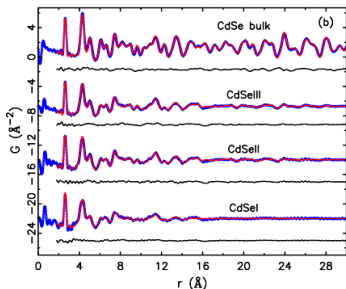
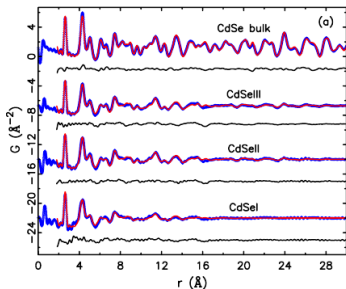


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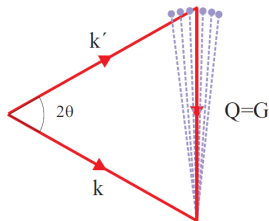
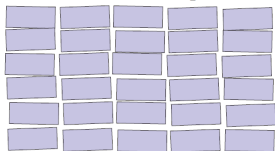
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The final values obtained in the fitting give particle sizes consistent with TEM and optical measurements. The fits also show that the bulk sample has only about 33% stacking faults while the nanoparticles have 50%

"Quantitative size-dependent structure and strain determination of CdSe nanoparticles using atomic pair distribution function analysis," A.S. Masadeh, et al. *Phys. Rev. B* **76**, 115413 (2007).

# Kinematical vs. dynamical diffraction

Mosaic blocks of small perfect crystals

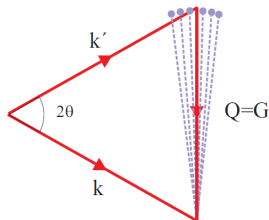
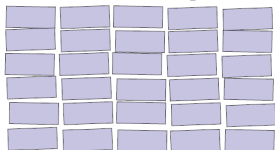


The kinematical approximation we have discussed so far applies to mosaic crystals. The size of the crystal is small enough that the wave field of the x-rays does not vary appreciably over the crystal.



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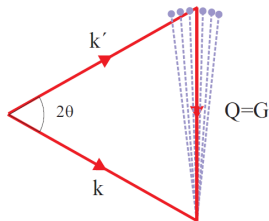
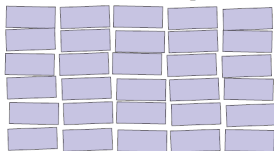


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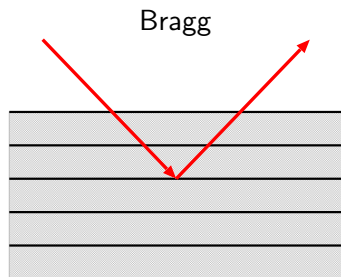
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For a perfect crystal, such as those used in monochromators, things are very different and we have to treat them specially using dynamical diffraction theory.

This theory takes into account multiple reflections, and attenuation of the x-ray beam as it propagates through the perfect crystal.

# Bragg & Laue geometries

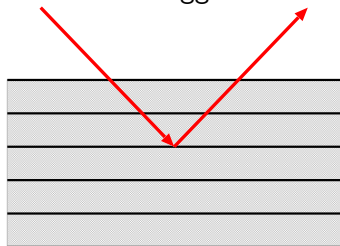
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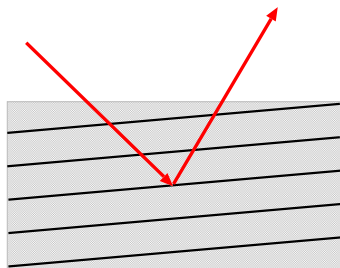
symmetric

# Bragg & Laue geometries

Bragg



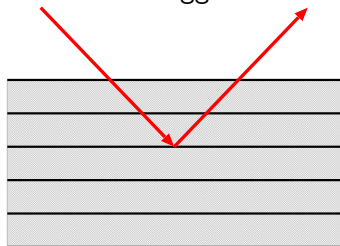
symmetric



asymmetric

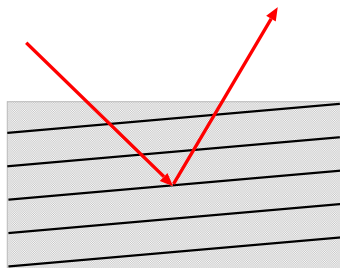
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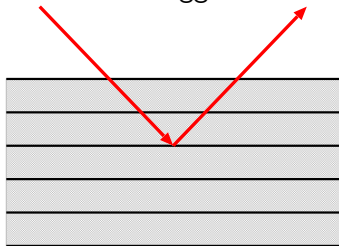
Laue



asymmetric

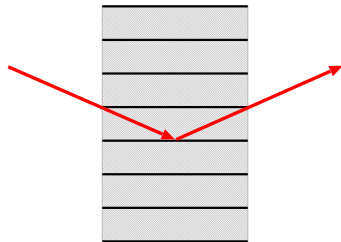
# Bragg & Laue geometries

Bragg

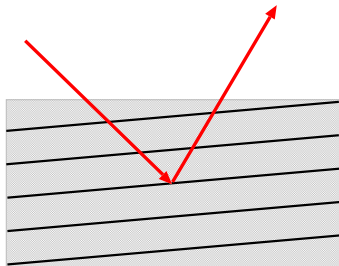


symmetric

Laue

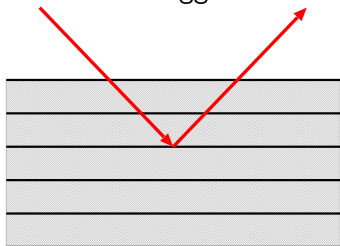


asymmetric

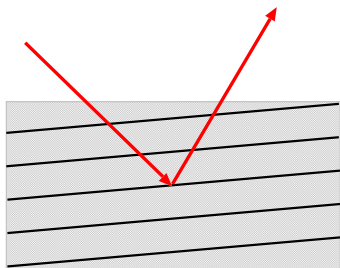


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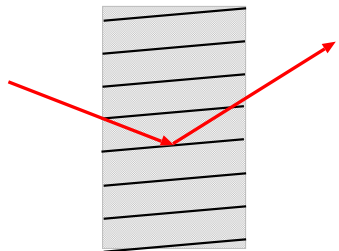
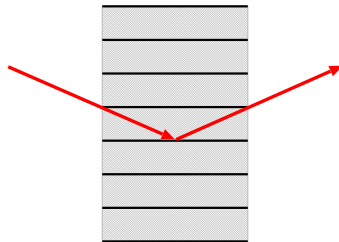


symmetric



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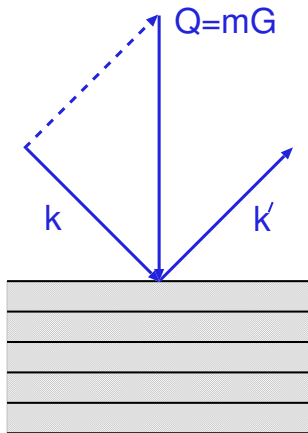


# Scattering geometry

Consider symmetric Bragg geometry

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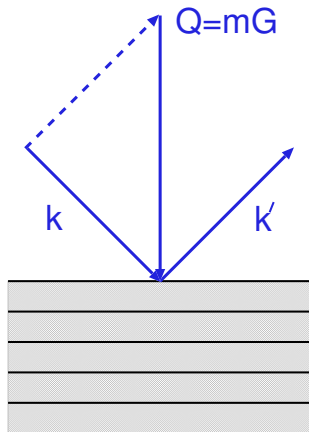
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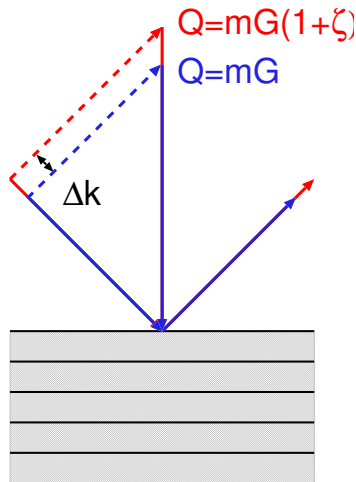
Consider symmetric Bragg geometry

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This defines a spread of scattering vectors such that

$$\zeta = \frac{\Delta Q}{Q} = \frac{\Delta k}{k}$$

called the relative energy or wavelength bandwidth

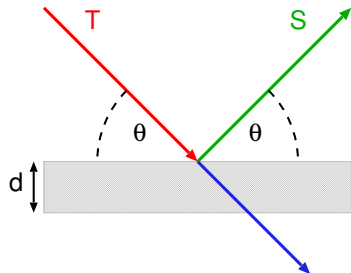


## Dynamical diffraction - Darwin approach

The Darwin approach treats a perfect crystal as an infinite stack of atomic planes.

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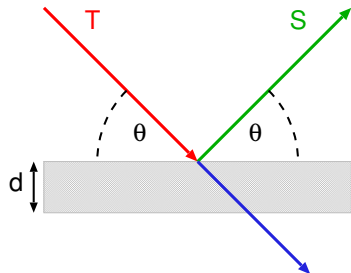
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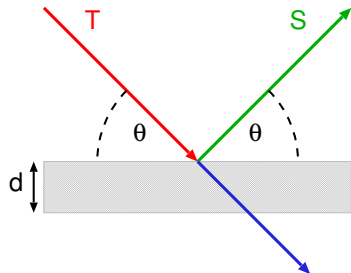
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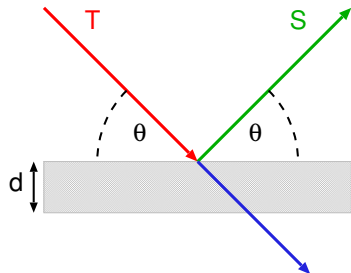
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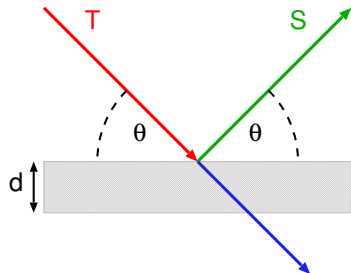
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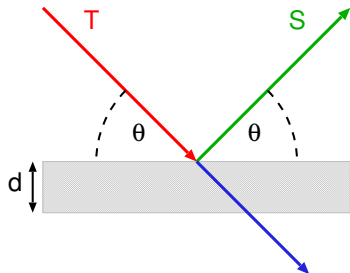
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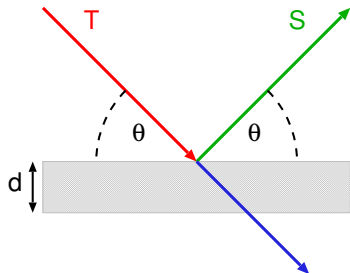
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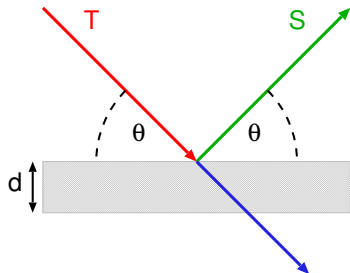
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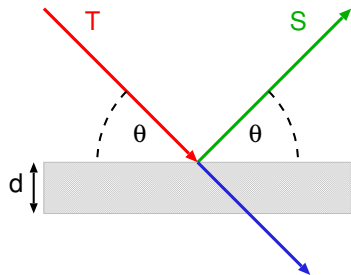


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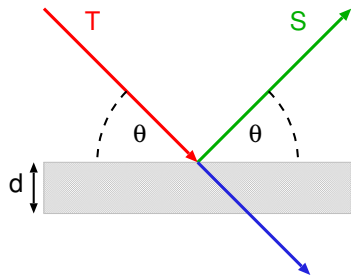
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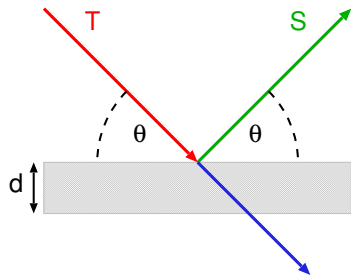
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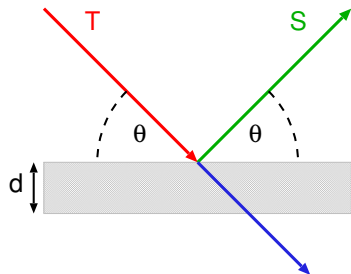
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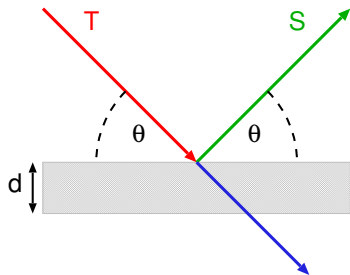
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where  $F_0$  is the forward scattering factor  
at  $Q = \theta = 0$



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